

Notice of References Cited	Application/Control No. 10/506,497		Applicant(s)/Patent Under Reexamination NYGARD, EINAR	
	Examiner Patrick J. Lee		Art Unit 2878	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,852,566 B2	02-2005	Yaung, Dun-Nian	438/74
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
	O					
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NON-PATENT DOCUMENTS

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